



 **POWER**™



PFU4N70EG / PFD4N70EG

FEATURES

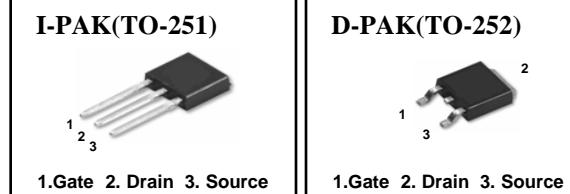
- Originative New Design
- 100% EAS Test
- Rugged Gate Oxide Technology
- Extremely Low Intrinsic Capacitances
- Remarkable Switching Characteristics
- Unequalled Gate Charge : 10 nC (Typ.)
- Extended Safe Operating Area
- Lower $R_{DS(ON)}$: 2.3 Ω (Typ.) @ $V_{GS}=10V$
- Halogen Free

APPLICATION

- Low power battery chargers
- Switch mode power supply (SMPS)
- DC-AC converters.

PFU4N70EG/PFD4N70EG 700V N-Channel MOSFET

BV_{DSS} = 700 V
R_{DS(on)} = 2.3 Ω
I_D = 2.85 A



Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Value	Units
V_{DSS}	Drain-Source Voltage	700	V
I_D	Drain Current – Continuous ($T_C=25^\circ\text{C}$)	2.85	A
	Drain Current – Continuous ($T_C=100^\circ\text{C}$)	1.8	A
I_{DM}	Drain Current – Pulsed	(Note 1)	A
V_{GS}	Gate-Source Voltage	± 30	V
E_{AS}	Single Pulsed Avalanche Energy	(Note 2)	mJ
I_{AR}	Avalanche Current	(Note 1)	A
E_{AR}	Repetitive Avalanche Energy	(Note 1)	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	V/ns
P_D	Total Power Dissipation ($T_A=25^\circ\text{C}$) *	2.5	W
	Power Dissipation ($T_C=25^\circ\text{C}$)	50	W
	- Derate above 25°C	0.4	W/°C
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	°C
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	2.5	°C/W
$R_{\theta JA}$	Junction-to-Ambient*	--	50	
$R_{\theta JA}$	Junction-to-Ambient	--	110	

* When mounted on the minimum pad size recommended (PCB Mount)

Electrical Characteristics $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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On Characteristics

V_{GS}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	2.5	--	4.5	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$, $I_D = 2.0 \text{ A}$	--	2.3	2.8	Ω

Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$, $I_D = 250 \mu\text{A}$	700	--	--	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C	--	0.6	--	$\text{V}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 700 \text{ V}$, $V_{GS} = 0 \text{ V}$	--	--	10	μA
		$V_{DS} = 560 \text{ V}$, $T_C = 125^\circ\text{C}$	--	--	100	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}$, $V_{DS} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}$, $V_{DS} = 0 \text{ V}$	--	--	-100	nA

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1.0 \text{ MHz}$	--	585	760	pF
C_{oss}	Output Capacitance		--	63	82	pF
C_{rss}	Reverse Transfer Capacitance		--	4	6	pF

Switching Characteristics

$t_{d(on)}$	Turn-On Time	$V_{DS} = 350 \text{ V}$, $I_D = 4.0 \text{ A}$, $R_G = 25 \Omega$ (Note 4,5)	--	14	28	ns
t_r	Turn-On Rise Time		--	7.5	15	ns
$t_{d(off)}$	Turn-Off Delay Time		--	28	56	ns
t_f	Turn-Off Fall Time		--	6.5	13	ns
Q_g	Total Gate Charge	$V_{DS} = 560 \text{ V}$, $I_D = 4.0 \text{ A}$, $V_{GS} = 10 \text{ V}$ (Note 4,5)	--	10	15	nC
Q_{gs}	Gate-Source Charge		--	3.2	--	nC
Q_{gd}	Gate-Drain Charge		--	3.8	--	nC

Source-Drain Diode Maximum Ratings and Characteristics

I_S	Continuous Source-Drain Diode Forward Current	--	--	2.85	A	
I_{SM}	Pulsed Source-Drain Diode Forward Current	--	--	11.4		
V_{SD}	Source-Drain Diode Forward Voltage	$I_S = 4.0 \text{ A}$, $V_{GS} = 0 \text{ V}$	--	--	1.5	V
trr	Reverse Recovery Time	$I_S = 4.0 \text{ A}$, $V_{GS} = 0 \text{ V}$ $dI_F/dt = 100 \text{ A}/\mu\text{s}$ (Note 4)	--	290	--	ns
Qrr	Reverse Recovery Charge		--	1.8	--	μC

Notes :

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=4.0\text{A}$, $V_{DD}=50\text{V}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$
- $I_{SD}\leq 4.0\text{A}$, $di/dt\leq 300\text{A}/\mu\text{s}$, $V_{DD}\leq BV_{DSS}$, Starting $T_J=25^\circ\text{C}$
- Pulse Test : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
- Essentially Independent of Operating Temperature

Typical Characteristics

Fig 1. Output Characteristics

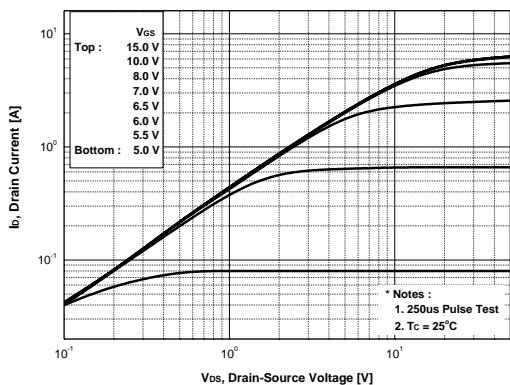


Fig 2. Transfer Characteristics

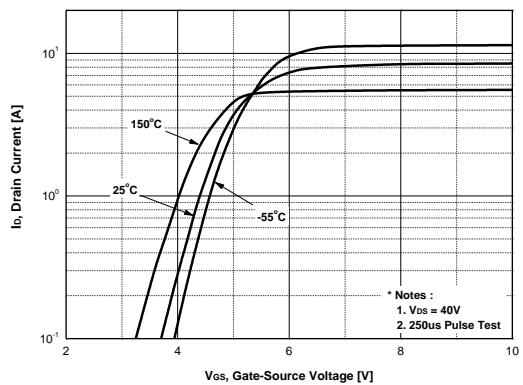


Fig 3. Static Drain-Source On Resistance

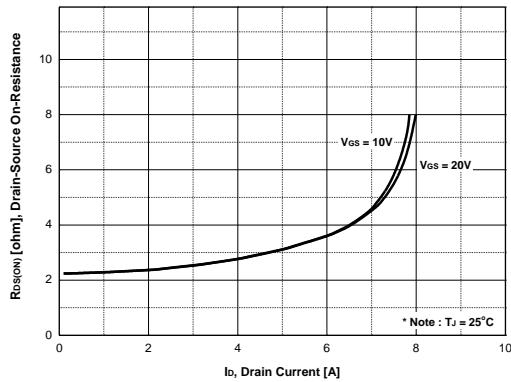


Fig 4. Source-Drain Diode Forward Voltage

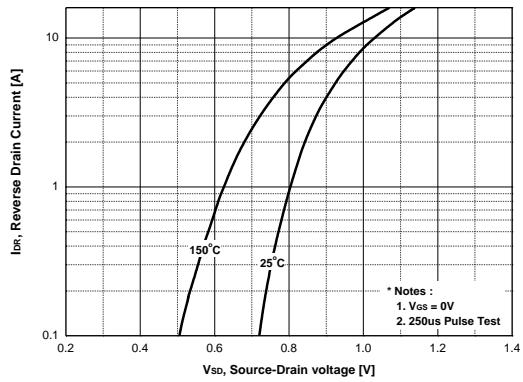


Fig 5. Capacitance Characteristics

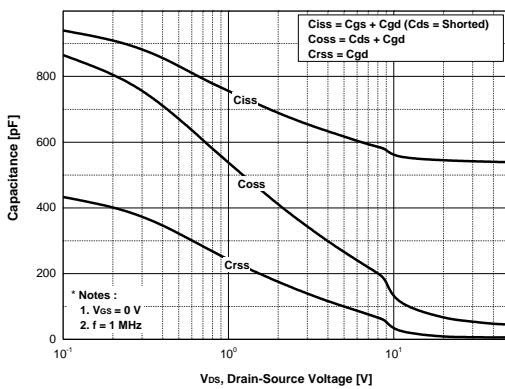
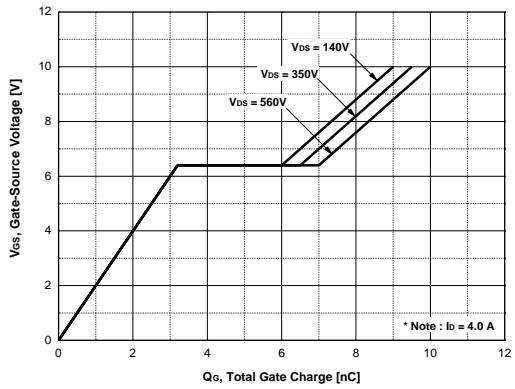


Fig 6. Gate Charge Characteristics



Typical Characteristics (continued)

Fig 7. BV_{DSS} vs. Junction Temperature

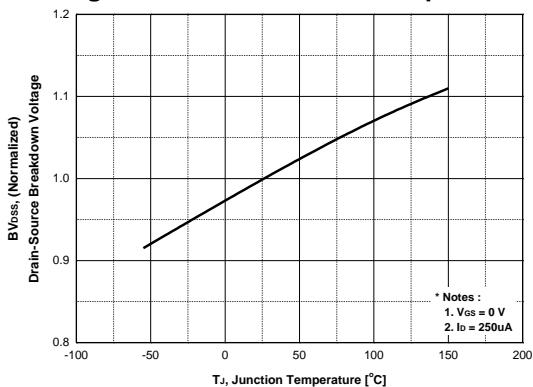


Fig 8. $R_{DS(ON)}$ vs. Junction Temperature

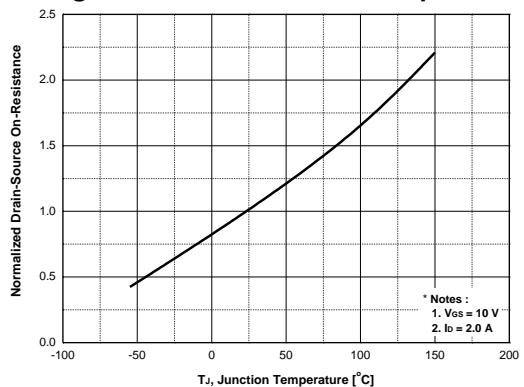


Fig 9. Safe Operation Area

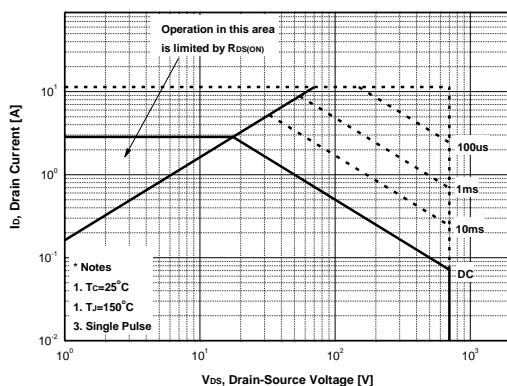


Fig 10. Maximum ID vs. Case Temperature

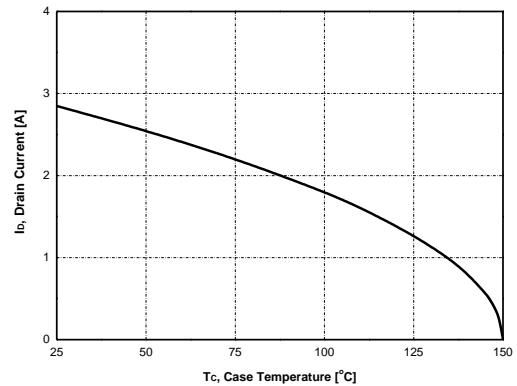
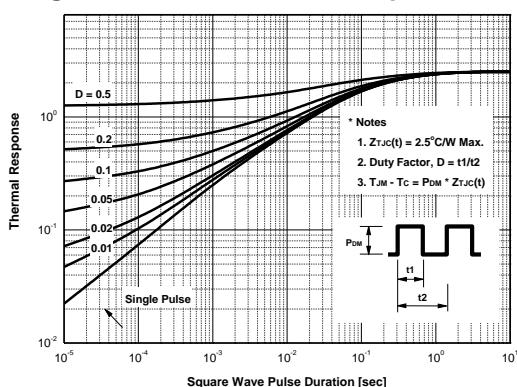


Fig 11. Transient Thermal Response Curve



Characteristics Test Circuit & Waveform

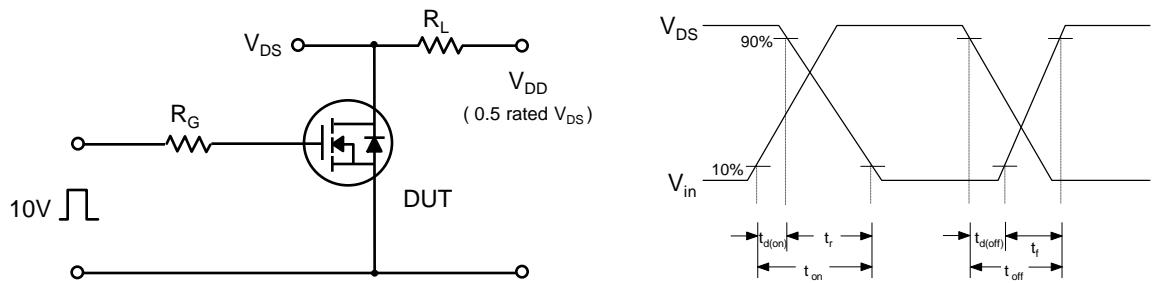


Fig 14. Resistive Switching Test Circuit & Waveforms

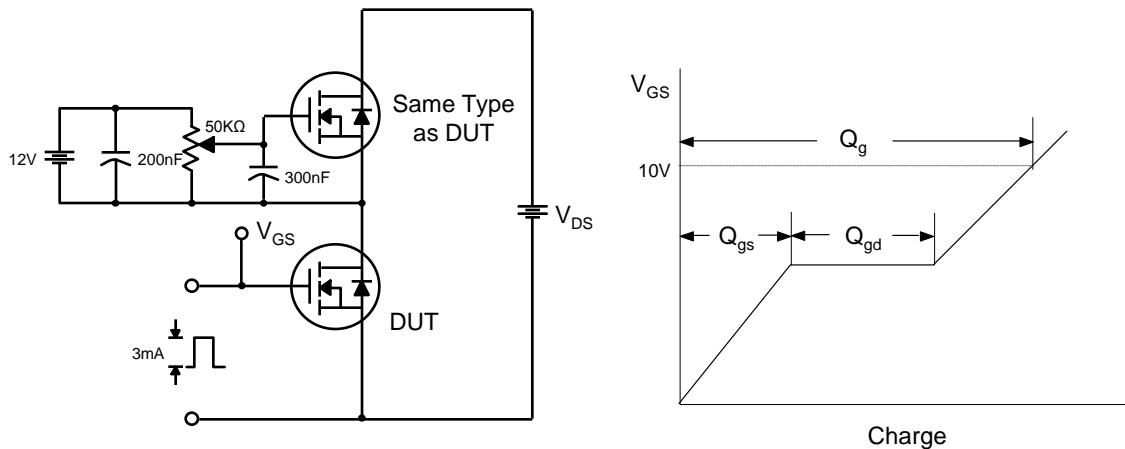


Fig 15. Gate Charge Test Circuit & Waveform

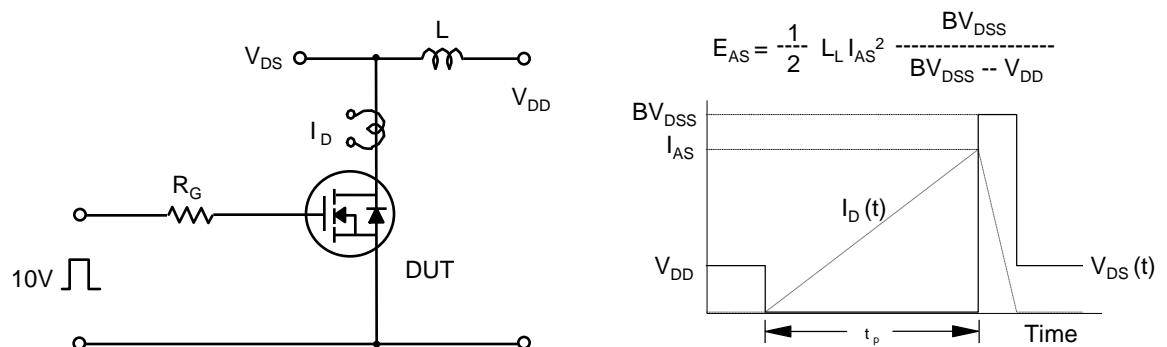


Fig 16. Unclamped Inductive Switching Test Circuit & Waveforms

Characteristics Test Circuit & Waveform (continued)

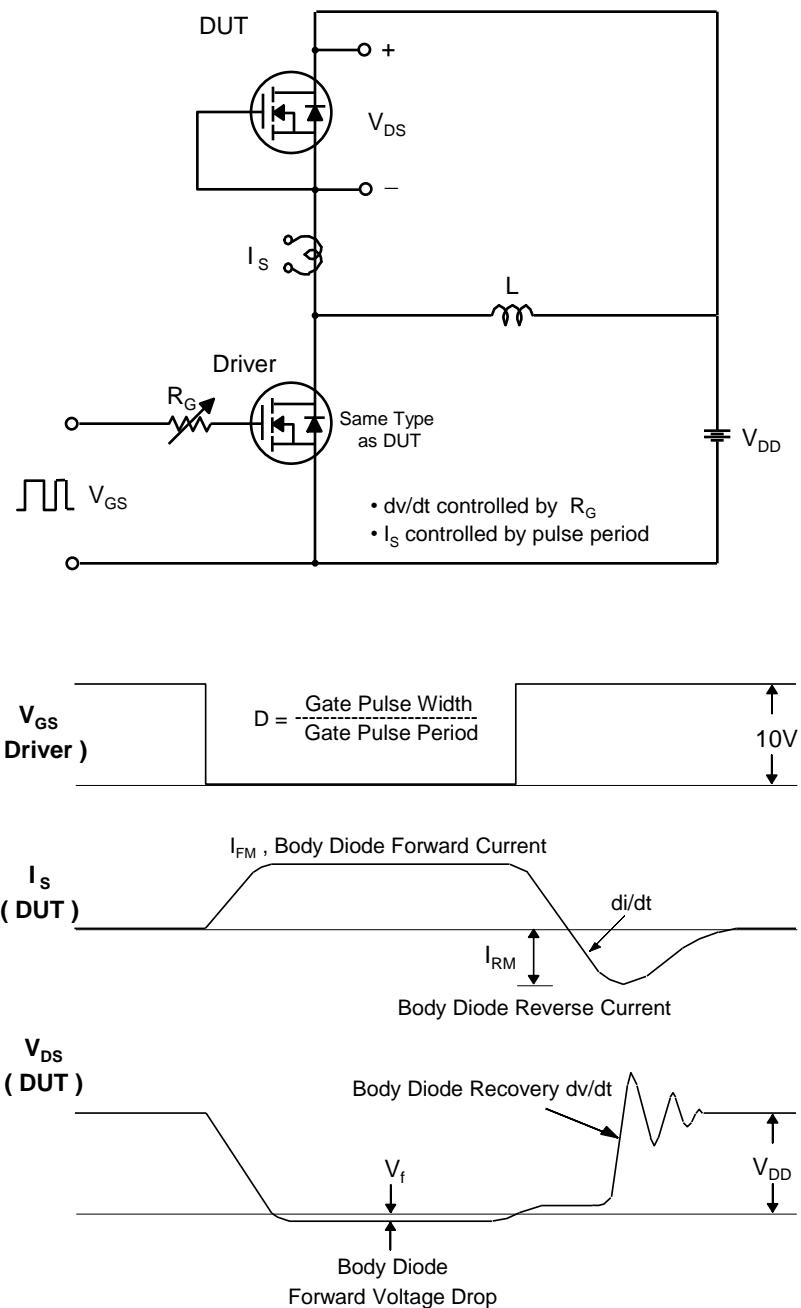
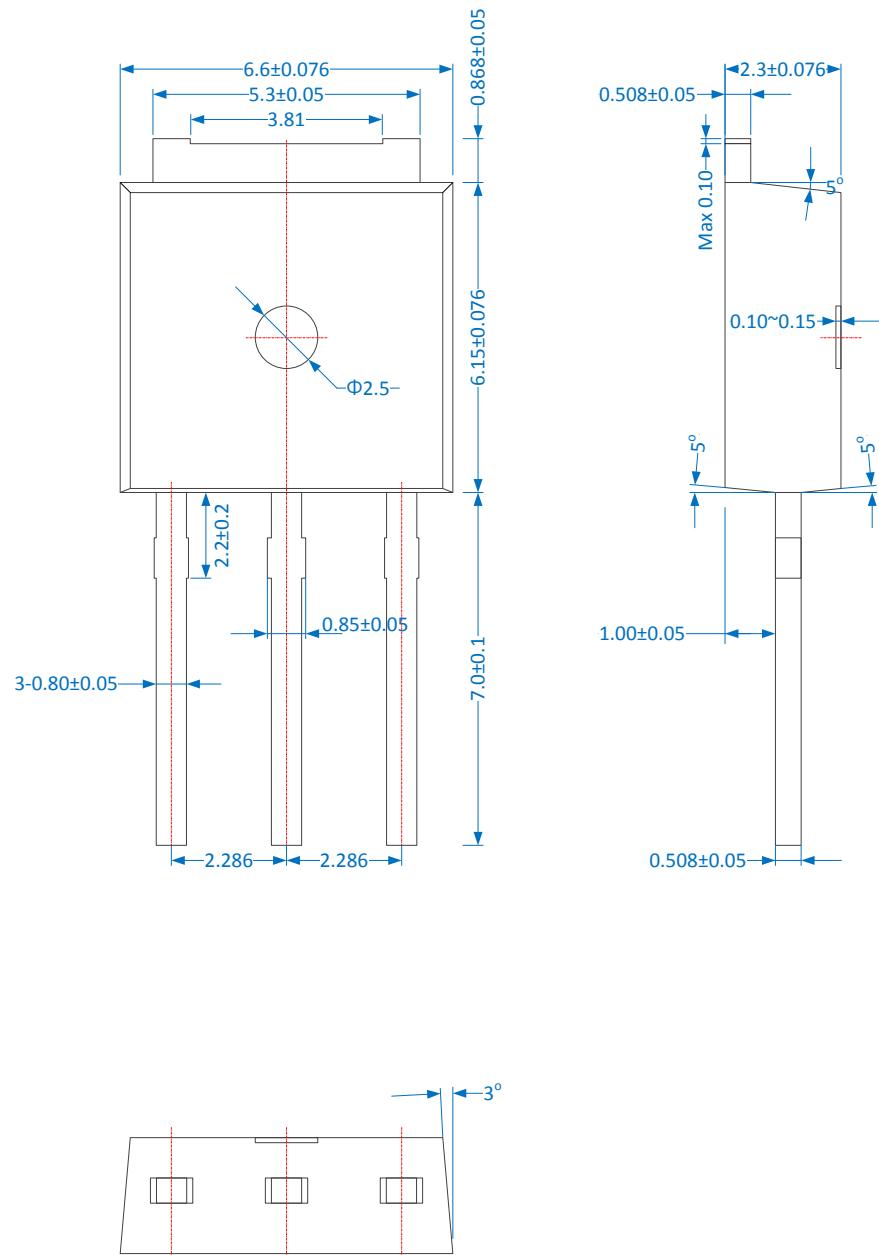


Fig 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

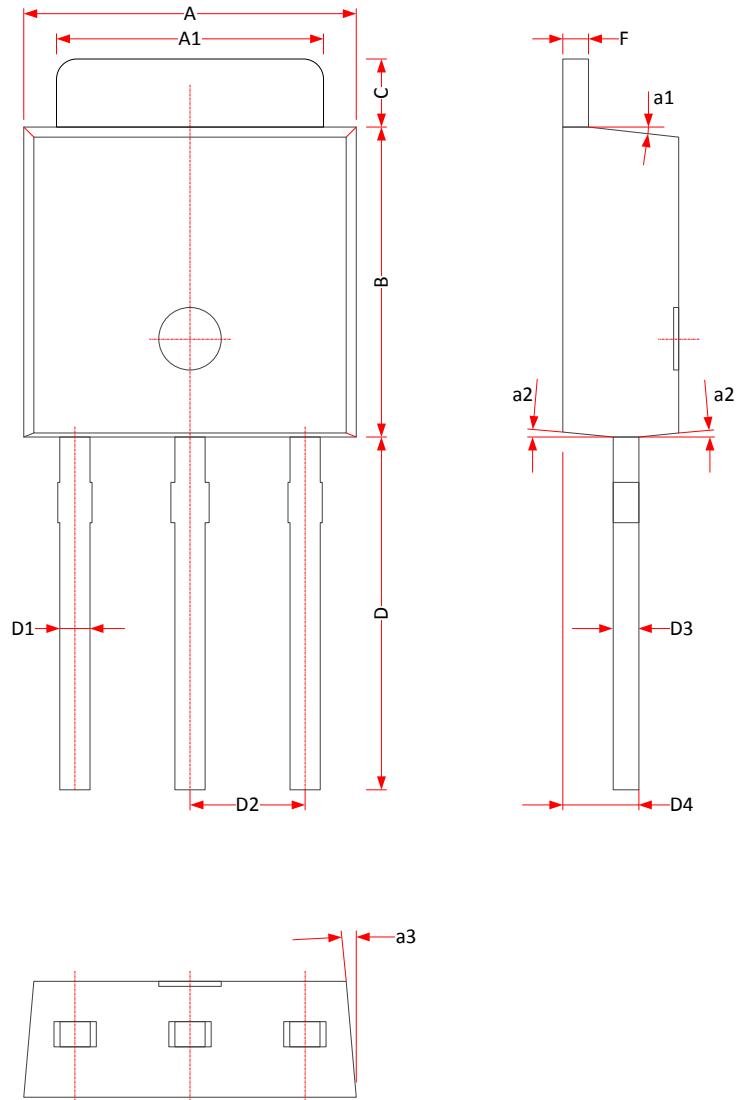
Package Dimension

I-PAK(TO-251) (Z)



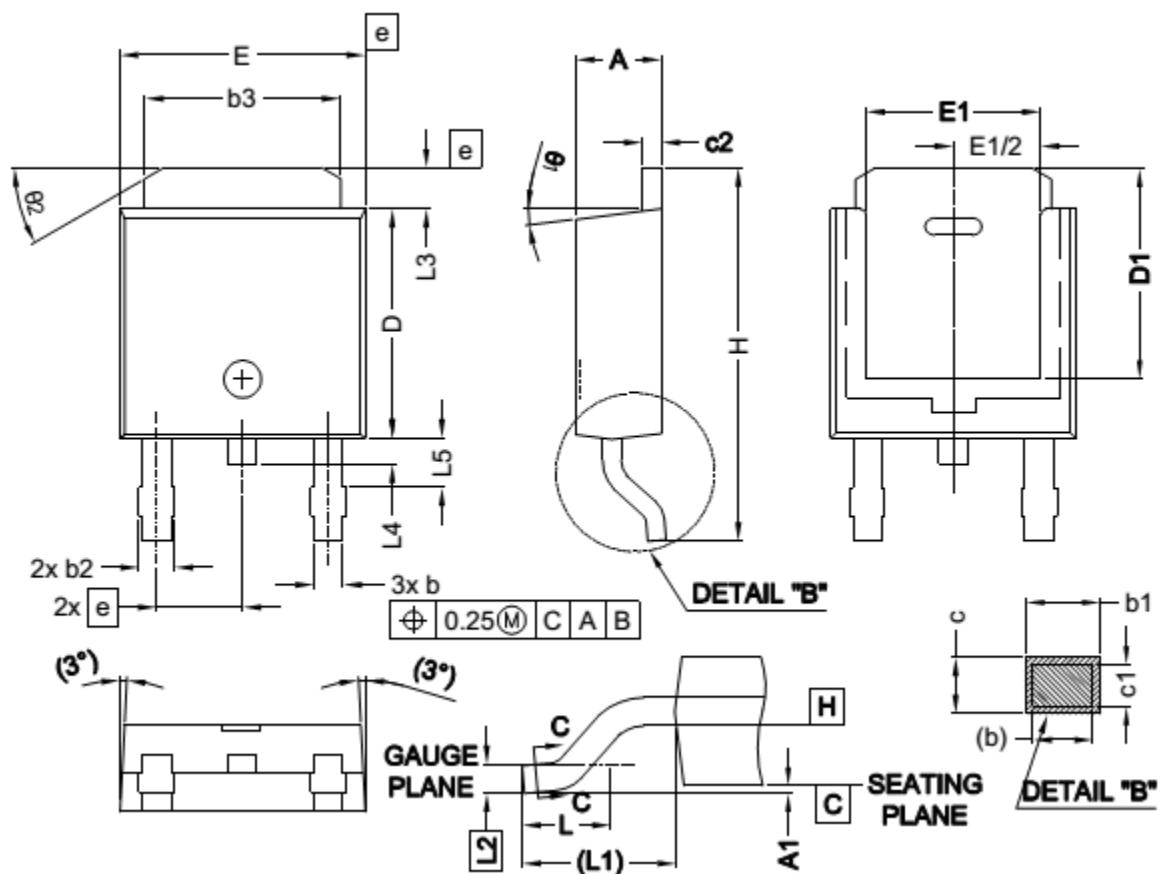
Package Dimension

I-PAK(TO-251) (h)



Package Dimension

D-PAK(TO-252) (a)



SYMBOL	MIN.	MAX.	SYMBOL	MIN.	MAX.	SYMBOL	MIN.	MAX.
A	2.18	2.39	E	6.35	6.73	φ1	0°	15°
A1	-	0.13	E1	4.32	-	φ2	25°	35°
b	0.640	0.884	e	2.29	BSC			
b1	0.65	0.79	H	9.94	10.34			
b2	0.760	1.124	L	1.50	1.78			
b3	4.95	5.46	L1	2.74	REF			
c	0.46	0.61	L2	0.51	BSC			
c1	0.41	0.56	L3	0.89	1.27			
c2	0.40	0.60	L4	-	1.02			
D	5.97	6.22	L5	1.140	1.492			
D1	5.21	-	φ	0°	10°			

Package Dimension**D-PAK(TO-252) (Z)**